

Docket No. 202686US2TTC

Paper #16
Power to Inspect
09/09/03

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Katsumi KANEHIRA, et al.

SERIAL NO: 09/774,621

GAU: 2863

FILED: February 1, 2001

EXAMINER: LAU, T. S.

FOR: DETERIORATION DIAGNOSTIC METHOD AND EQUIPMENT THEREOF

POWER TO INSPECT AND MAKE COPIES

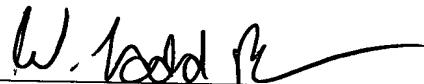
COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

The undersigned hereby grants Muralidhar Pai, and Khalid Quraishi the power to inspect the above-identified application and make copies thereof.

Respectfully Submitted,

OBLON, SPIVAK, McCLELLAND,
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